

Notice of References Cited	Application/Control No. 10/021,531	Applicant(s)/Patent Under Reexamination PHAN ET AL.	
	Examiner Binh X Tran	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,136,721	10-2000	Kumihashi et al.	438/714
	B	US-5,780,315	07-1998	Chao et al.	438/8
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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